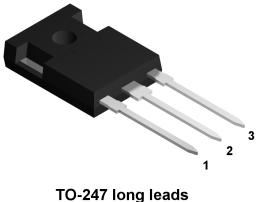
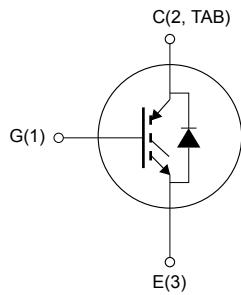


Trench gate field-stop, 650 V, 50 A, high-speed HB2 series IGBT in a TO-247 long leads package

Features



- Maximum junction temperature : $T_J = 175 \text{ }^{\circ}\text{C}$
- Low $V_{CE(\text{sat})} = 1.55 \text{ V}(\text{typ.}) @ I_C = 50 \text{ A}$
- Co-packaged protection diode
- Minimized tail current
- Tight parameter distribution
- Low thermal resistance
- Positive $V_{CE(\text{sat})}$ temperature coefficient



NC1E3C2T

Applications

- Welding
- Power factor correction

Description

The newest IGBT 650 V HB2 series represents an evolution of the advanced proprietary trench gate field-stop structure. The performance of the HB2 series is optimized in terms of conduction, thanks to a better $V_{CE(\text{sat})}$ behavior at low current values, as well as in terms of reduced switching energy. A diode used for protection purposes only is co-packaged in antiparallel with the IGBT. The result is a product specifically designed to maximize efficiency for a wide range of fast applications.



Product status link

[STGWA50HP65FB2](#)

Product summary

Order code	STGWA50HP65FB2
Marking	G50HP65FB2
Package	TO-247 long leads
Packing	Tube

1

Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-emitter voltage ($V_{GE} = 0$ V)	650	V
I_C	Continuous collector current at $T_C = 25$ °C	86	A
	Continuous collector current at $T_C = 100$ °C	53	A
$I_{CP}^{(1)(2)}$	Pulsed collector current	150	A
V_{GE}	Gate-emitter voltage	±20	V
	Transient gate-emitter voltage ($t_p \leq 10$ µs)	±30	
I_F	Continuous forward current at $T_C = 25$ °C	5	A
	Continuous forward current at $T_C = 100$ °C	5	
$I_{FP}^{(1)(2)}$	Pulsed forward current	10	A
P_{TOT}	Total power dissipation at $T_C = 25$ °C	272	W
T_{STG}	Storage temperature range	-55 to 150	°C
T_J	Operating junction temperature range	-55 to 175	°C

1. Pulse width is limited by maximum junction temperature.

2. Defined by design, not subject to production test.

Table 2. Thermal data

Symbol	Parameter	Value	Unit
R_{thJC}	Thermal resistance junction-case IGBT	0.55	°C/W
	Thermal resistance junction-case diode	5	
R_{thJA}	Thermal resistance junction-ambient	50	

2 Electrical characteristics

$T_C = 25^\circ\text{C}$ unless otherwise specified

Table 3. Static characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(\text{BR})\text{CES}}$	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	650			V
$V_{CE(\text{sat})}$	Collector-emitter saturation voltage	$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}$		1.55	2	V
		$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}, T_J = 125^\circ\text{C}$			1.8	
		$V_{GE} = 15 \text{ V}, I_C = 50 \text{ A}, T_J = 175^\circ\text{C}$			1.9	
		$I_F = 5 \text{ A}$		2	2.8	
V_F	Forward on-voltage	$I_F = 5 \text{ A}, T_J = 125^\circ\text{C}$		1.85		V
		$I_F = 5 \text{ A}, T_J = 175^\circ\text{C}$			1.75	
		$V_{CE} = V_{GE}, I_C = 1 \text{ mA}$	5	6	7	
I_{CES}	Collector cut-off current	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}$			25	μA
I_{GES}	Gate-emitter leakage current	$V_{CE} = 0 \text{ V}, V_{GE} = \pm 20 \text{ V}$			± 250	nA

Table 4. Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}, V_{GE} = 0 \text{ V}$	-	2928	-	pF
C_{oes}	Output capacitance		-	162	-	
C_{res}	Reverse transfer capacitance		-	78	-	
Q_g	Total gate charge	$V_{CC} = 520 \text{ V}, I_C = 50 \text{ A}, V_{GE} = 0 \text{ to } 15 \text{ V}$ (see Figure 27. Gate charge test circuit)	-	151	-	nC
Q_{ge}	Gate-emitter charge		-	30	-	
Q_{gc}	Gate-collector charge		-	63	-	

Table 5. Switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(\text{off})}$	Turn-off delay time	$V_{CC} = 400 \text{ V}, I_C = 50 \text{ A},$	-	115	-	ns
t_f	Current fall time	$V_{GE} = 15 \text{ V}, R_G = 4.7 \Omega$	-	40	-	ns
$E_{\text{off}}^{(1)}$	Turn-off switching energy	(see Figure 26. Test circuit for inductive load switching)	-	580	-	μJ
$t_{d(\text{off})}$	Turn-off delay time	$V_{CC} = 400 \text{ V}, I_C = 50 \text{ A},$	-	135	-	ns
t_f	Current fall time	$V_{GE} = 15 \text{ V}, R_G = 4.7 \Omega,$ $T_J = 175 \text{ }^\circ\text{C}$	-	90	-	ns
$E_{\text{off}}^{(1)}$	Turn-off switching energy	(see Figure 26. Test circuit for inductive load switching)	-	1090	-	μJ

1. Including the tail of the collector current.

Table 6. Diode switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
t_{rr}	Reverse recovery time		-	140	-	ns
Q_{rr}	Reverse recovery charge	$I_F = 5 \text{ A}, V_R = 400 \text{ V},$	-	21	-	nC
I_{rrm}	Reverse recovery current	$V_{GE} = 15 \text{ V}, dI/dt = 1000 \text{ A}/\mu\text{s}$	-	6.6	-	A
dI_{rr}/dt	Peak rate of fall of reverse recovery current during t_b	(see Figure 29. Diode reverse recovery waveform)	-	430	-	$\text{A}/\mu\text{s}$
E_{rr}	Reverse recovery energy		-	1.6	-	μJ
t_{rr}	Reverse recovery time		-	200	-	ns
Q_{rr}	Reverse recovery charge	$I_F = 5 \text{ A}, V_R = 400 \text{ V},$	-	47.3	-	nC
I_{rrm}	Reverse recovery current	$V_{GE} = 15 \text{ V}, dI/dt = 1000 \text{ A}/\mu\text{s},$ $T_J = 175 \text{ }^\circ\text{C}$	-	9.6	-	A
dI_{rr}/dt	Peak rate of fall of reverse recovery current during t_b	(see Figure 29. Diode reverse recovery waveform)	-	428	-	$\text{A}/\mu\text{s}$
E_{rr}	Reverse recovery energy		-	3.2	-	μJ

2.1 Electrical characteristics (curves)

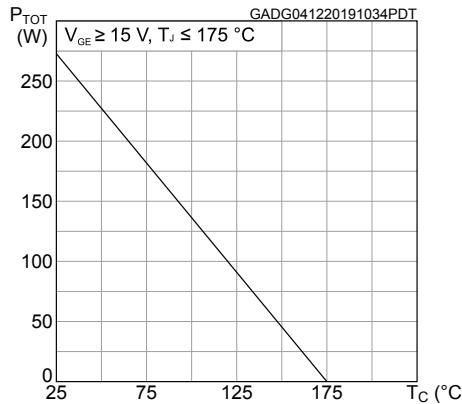
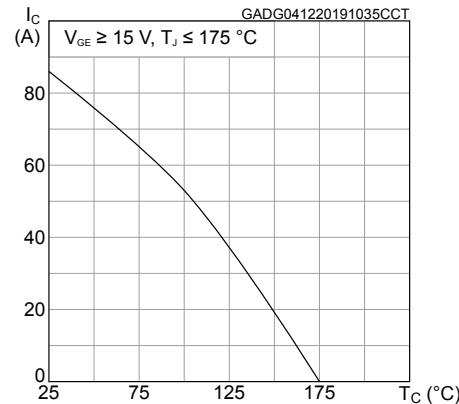
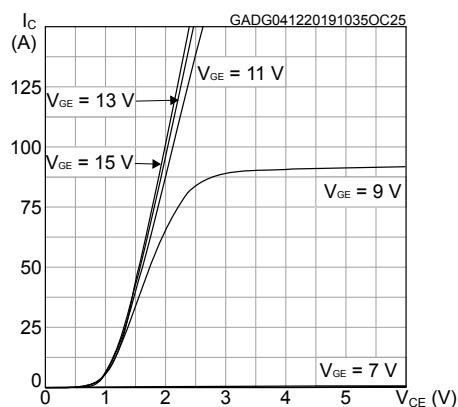
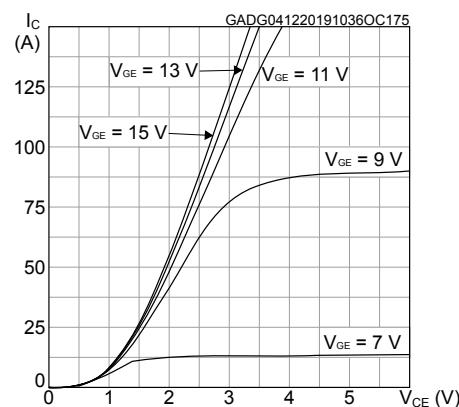
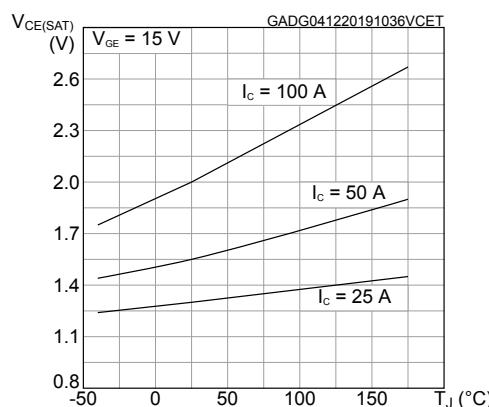
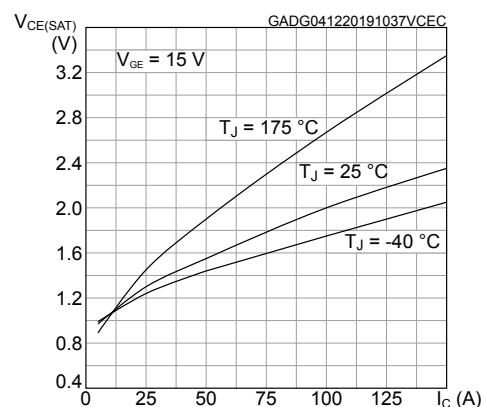
Figure 1. Power dissipation vs case temperature

Figure 2. Collector current vs case temperature

Figure 3. Output characteristics ($T_J = 25^\circ\text{C}$)

Figure 4. Output characteristics ($T_J = 175^\circ\text{C}$)

Figure 5. $V_{CE(\text{sat})}$ vs junction temperature

Figure 6. $V_{CE(\text{sat})}$ vs collector current


Figure 7. Forward bias safe operating area

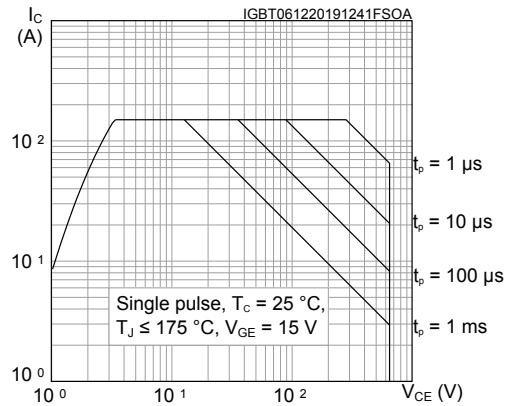


Figure 8. Transfer characteristics

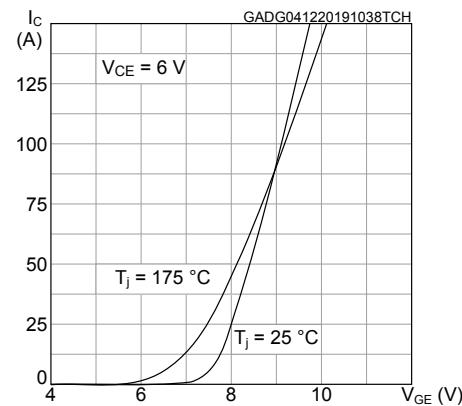


Figure 9. Diode VF vs forward current

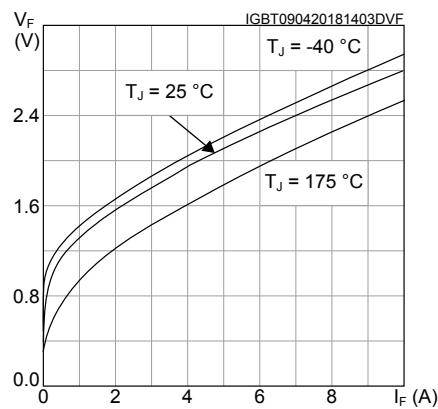


Figure 10. Normalized VGE(th) vs junction temperature

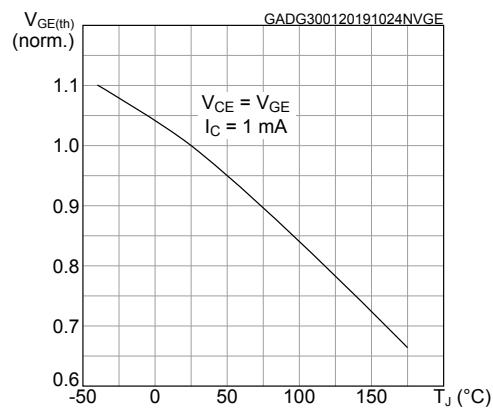


Figure 11. Normalized V(BR)CES vs junction temperature

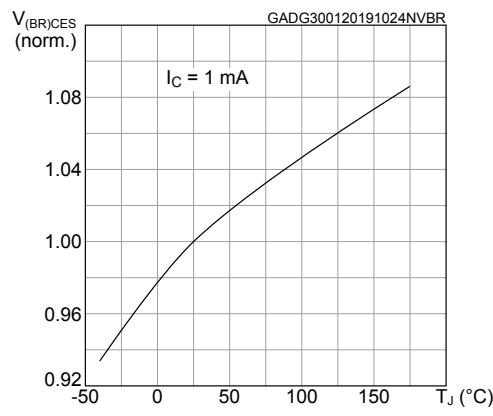


Figure 12. Capacitance variations

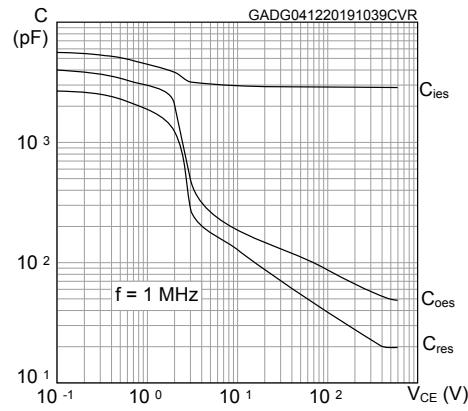


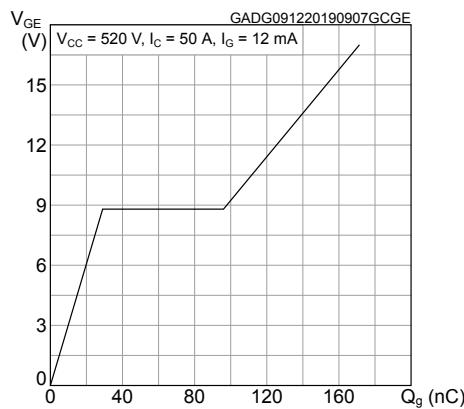
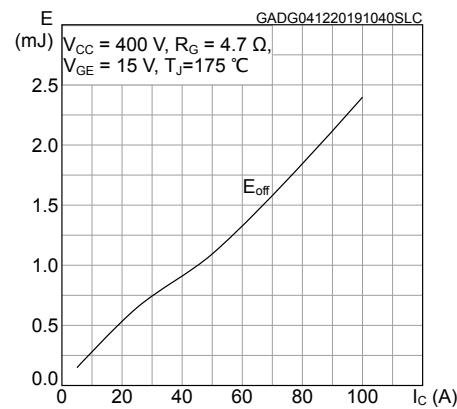
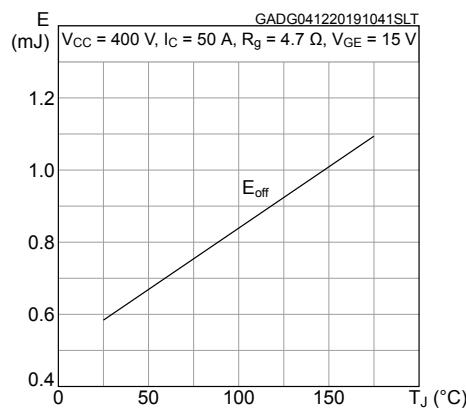
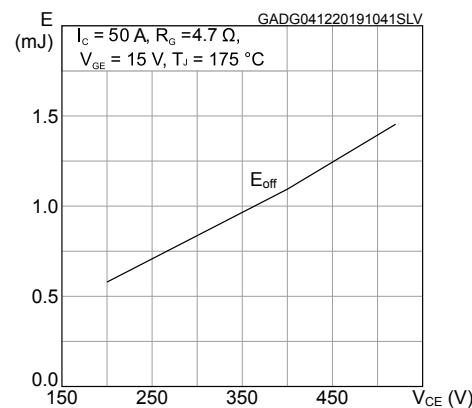
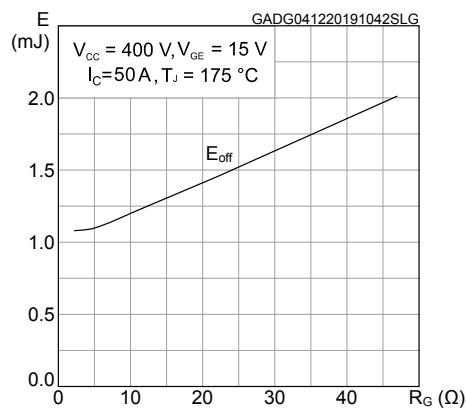
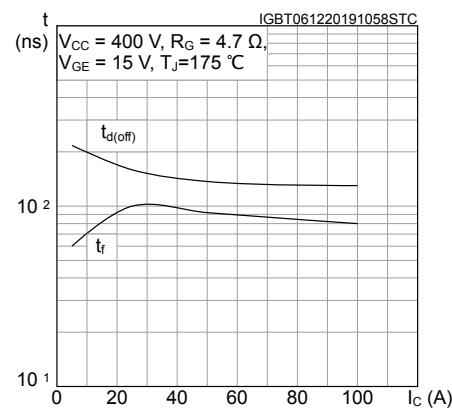
Figure 13. Gate charge vs gate-emitter voltage

Figure 14. Switching energy vs collector current

Figure 15. Switching energy vs temperature

Figure 16. Switching energy vs collector emitter voltage

Figure 17. Switching energy vs gate resistance

Figure 18. Switching times vs collector current


Figure 19. Switching times vs gate resistance

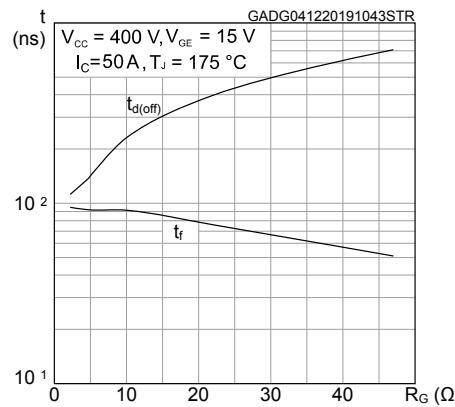


Figure 20. Reverse recovery current vs diode current slope

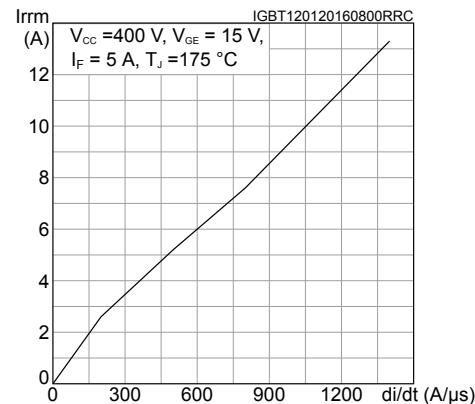


Figure 21. Reverse recovery time vs diode current slope

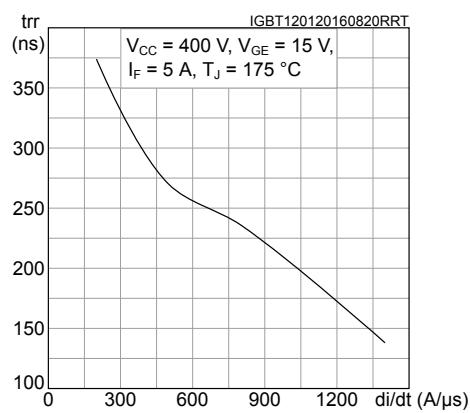


Figure 22. Reverse recovery charge vs diode current slope

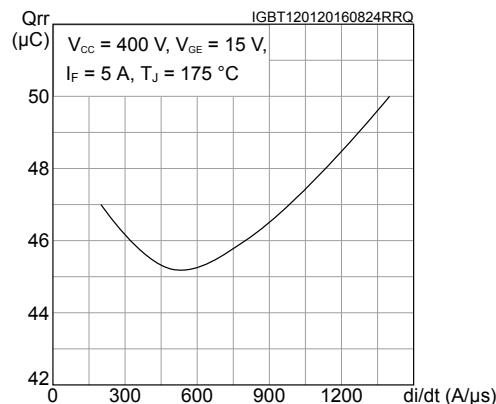


Figure 23. Reverse recovery energy vs diode current slope

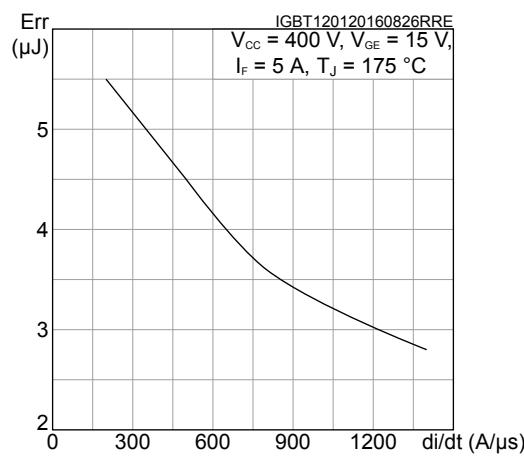
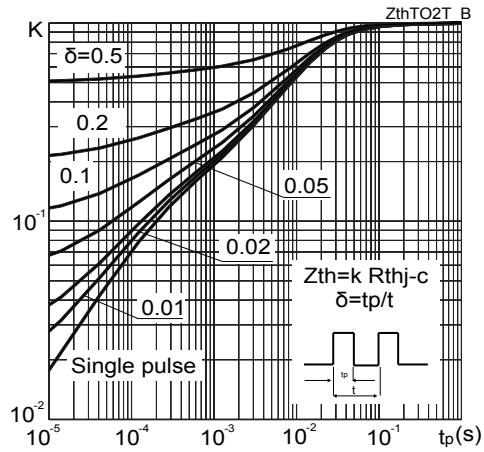
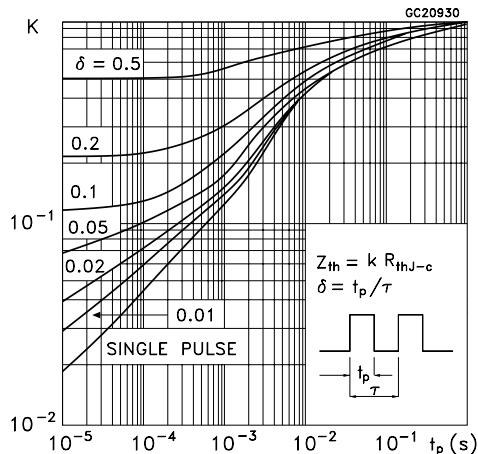
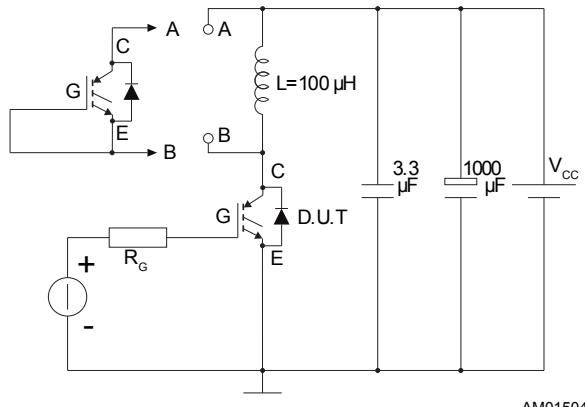


Figure 24. Thermal impedance for IGBT**Figure 25. Thermal impedance for diode**

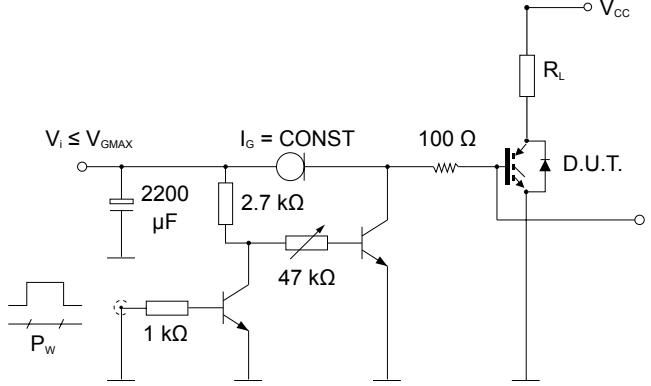
3 Test circuits

Figure 26. Test circuit for inductive load switching



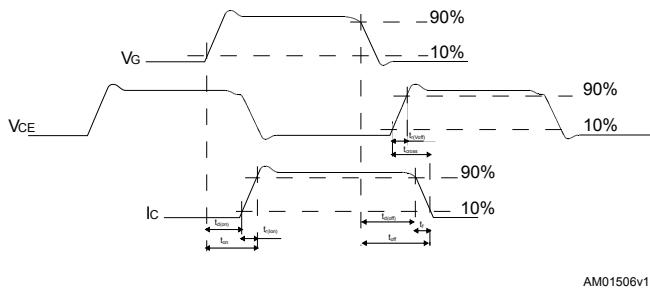
AM01504v1

Figure 27. Gate charge test circuit



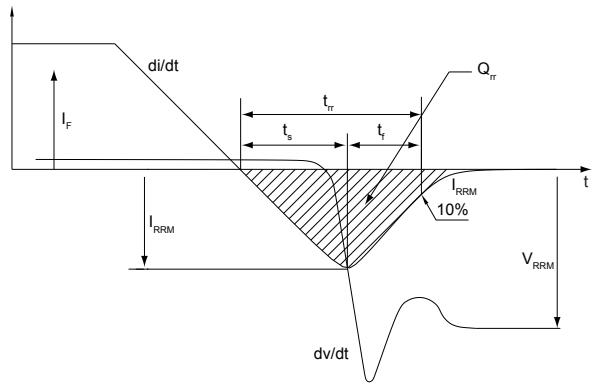
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Figure 28. Switching waveform



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Figure 29. Diode reverse recovery waveform



GADG180720171418SA

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 TO-247 long leads package information

Figure 30. TO-247 long leads package outline

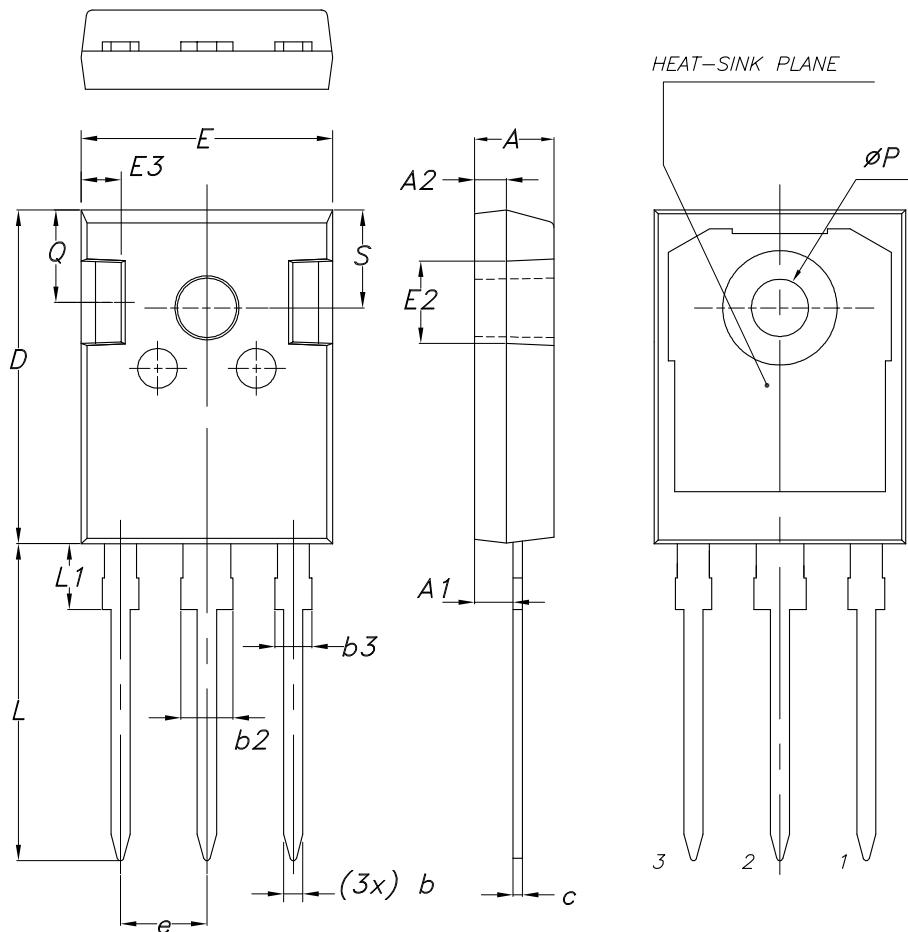


Table 7. TO-247 long leads package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
c	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
P	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

Revision history

Table 8. Document revision history

Date	Version	Changes
05-Dec-2019	1	First release.

Contents

1	Electrical ratings	2
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